TOSHIBA MT4S04A

TENTATIVE

TOSHIBA TRANSISTOR SILICON NPN EPITAXIAL PLANAR TYPE

M T 4 S 0 4 A

VHF~UHF BAND LOW NOISE AMPLIFIER APPLICATIONS

Low Noise: Figure: NF = 1.2 dB

High Gain: Gain = 13.5 dB (f = 1 GHz)

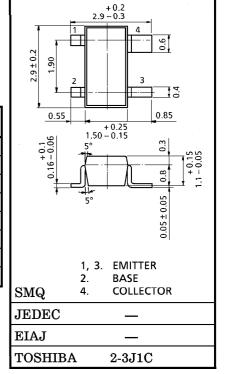
MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Collector-Base Voltage	v_{CBO}	10	V
Collector-Emitter Voltage	v_{CEO}	5	V
Emitter-Base Voltage	V_{EBO}	2	V
Base Current	$_{ m IC}$	40	mA
Collector Current	$I_{\mathbf{B}}$	10	mA
Collector Power Dissipation	$P_{\mathbf{C}}$	150	mW
Junction Temperature	$T_{ m j}$	125	$^{\circ}\mathrm{C}$
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~125	$^{\circ}\mathrm{C}$

MARKING



Unit in mm



Weight: 0.012 g

MICROWAVE CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Transition Frequency	f _T (1)	$V_{CE} = 1 \text{ V}, I_{C} = 5 \text{ mA}$	2	4.5	_	GHz
	f _T (2)	$ m V_{CE}=3~V,~I_{C}=7~mA$	5	7	_	
Insertion Gain	$ S_{21e} ^2(1)$	$V_{ ext{CE}} = 1 \text{ V}, \text{ I}_{ ext{C}} = 5 \text{ mA},$ $f = 1 \text{ GHz}$	8	10	_	- dB
	$ S_{21e} ^2$ (2)	$V_{CE} = 3 \text{ V}, I_{C} = 20 \text{ mA}, $ f = 1 GHz	11.5	13.5	_	
Noise Figure -	NF (1)	$V_{ ext{CE}} = 1 \text{ V}, \text{ I}_{ ext{C}} = 5 \text{ mA},$ $f = 1 \text{ GHz}$		1.3	2.2	- dB
	NF (2)	$V_{ ext{CE}} = 3 \text{ V}, \text{ I}_{ ext{C}} = 7 \text{ mA},$ $f = 1 \text{ GHz}$	_	1.2	2	uБ

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	ICBO	$V_{CB} = 5 V, I_E = 0$		_	0.1	μ A
Emitter Cut-off Current	$I_{ m EBO}$	$V_{EB} = 1 V, I_{C} = 0$	_	_	1	μ A
DC Current Gain	$_{ m h_{FE}}$	$V_{CE} = 1 V$, $I_{C} = 5 mA$	80	_	160	_
Reverse Transfer	$_{\mathrm{C_{re}}}$	$V_{CB} = 1 V, I_{E} = 0, f = 1 MHz$		0.75	1 1	рF
Capacitance	re	(Note)	_	0.75	1.1	pr

(Note): C_{re} is measured by 3 terminal method with capacitance bridge.

CAUTION

This device electrostatic sensitivity. Please handle with caution.